FAIRCHILD SEMICONDUCTOR®

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FPDB60PH60B

Smart Power Module for Front-End Rectifier

General Description

FPDB60PH60B is an advanced smart power module of PFC(Power Factor Correction) that Fairchild has newly developed and designed mainly targeting mid-power application especially for an air conditioners. It combines optimized circuit protection and drive IC matched to high frequency switching IGBTs. System reliability is futher enhanced by the integrated under-voltage lock-out and over-current protection function.

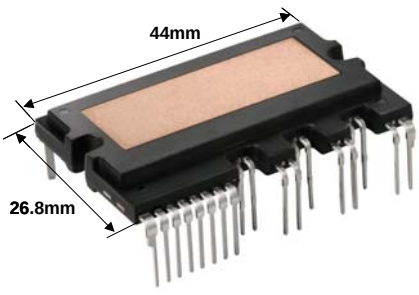
Features

- Low thermal resistance due to AlN-DBC substrate
- 600V-60A 2-phase IGBT PWM semi-converter including a drive IC for gate driving and protection
- Typical switching frequency of 20kHz
- Isolation rating of 2500Vrms/min.

Applications

- AC 180V ~ 264V single-phase front-end rectifier

Top View



Bottom View



Fig. 1.

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Integrated Power Functions

- PFC converter for single-phase AC/DC power conversion (Please refer to Fig. 3)

Integrated Drive, Protection and System Control Functions

- For IGBTs: Gate drive circuit, Overcurrent circuit protection (OC), Control supply circuit under-voltage (UV) protection
- Fault signaling: Corresponding to a UV fault
- Input interface: 5V CMOS/LSTTL compatible, Schmitt trigger input

Pin Configuration

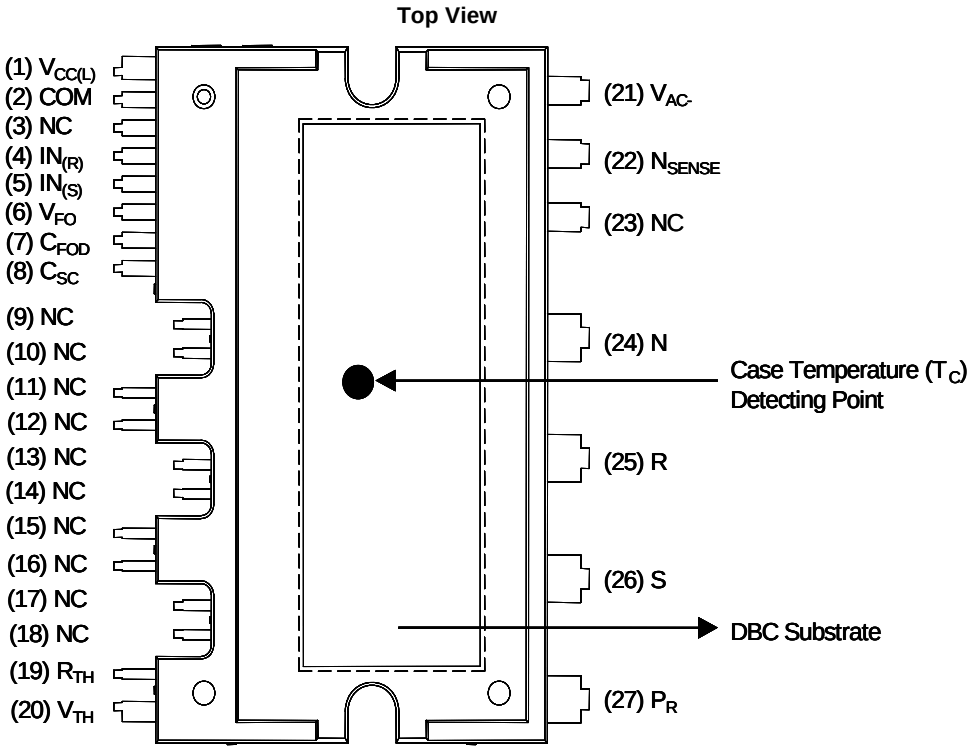


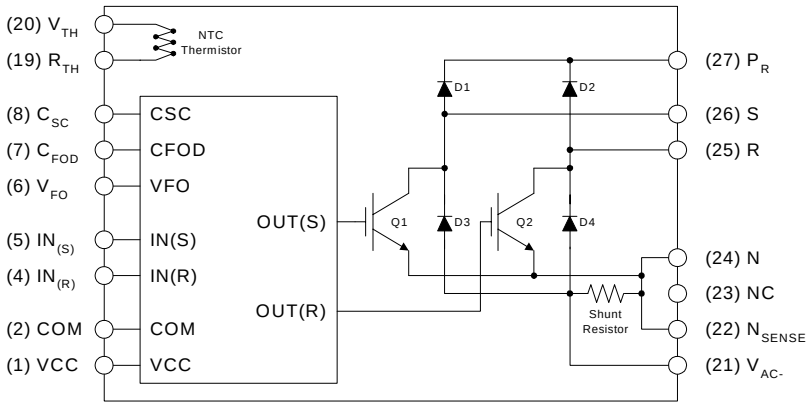
Fig. 2.

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Pin Descriptions

Pin Number	Pin Name	Pin Description
1	V_{CC}	Common Bias Voltage for IC and IGBTs Driving
2	COM	Common Supply Ground
4	$IN_{(R)}$	Signal Input for Low-side R-phase IGBT
5	$IN_{(S)}$	Signal Input for Low-side S-phase IGBT
6	V_{FO}	Fault Output
7	C_{FOD}	Capacitor for Fault Output Duration Time Selection
8	C_{SC}	Capacitor (Low-pass Filter) for Over Current Detection
19	$R_{(TH)}$	NTC Thermistor terminal
20	$V_{(TH)}$	NTC Thermistor terminal
21	V_{AC-}	Current Sensing Terminal
22	N_{SENSE}	Current Sensing Reference Terminal
24	N	Negative Rail of DC–Link
25	R	Output for R Phase
26	S	Output for S Phase
27	P_R	Positive Rail of DC–Link
3, 9~18, 23	NC	No Connection

Internal Equivalent Circuit and Input/Output Pins



Note :
1) Converter is composed of two IGBTs including four diodes and one IC which has gate driving and protection functions.

Fig. 3.

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Absolute Maximum Ratings (T_J = 25°C, Unless Otherwise Specified)

Converter Part

Item	Symbol	Condition	Rating	Unit
Supply Voltage	V_i	Applied between R-S	264	V_{RMS}
Supply Voltage (Surge)	$V_{i(Surge)}$	Applied between R-S	500	V
Output Voltage	V_{PN}	Applied between P- N	450	V
Output Voltage (Surge)	$V_{PN(Surge)}$	Applied between P- N	500	V
Collector-emitter Voltage	V_{CES}		600	V
Each IGBT collector current	$\pm I_C$	T_C = 25°C	60	A
Each IGBT collector current (Peak)	$\pm I_{CP}$	T_C = 25°C, Under 1ms pulse width	90	A
Collector Dissipation	P_C	T_C = 25°C per One IGBT	178	W
Repetitive Peak Reverse Voltage	V_{RRM}		600	V
Peak Forward Surge Current	I_{FSM}	Single half sine-wave	350	A
Power Rating of Shunt Resistor	P_{RSH}	T_C < 125°C	2	W
Operating Junction Temperature	T_J	(Note 1)	-40 ~ 150	°C

Note :

1. The maximum junction temperature rating of the power chips integrated within the SPM is 150°C(@$T_C \leq$ 100°C). However, to insure safe operation of the SPM, the average junction temperature should be limited to $T_{J(ave)} \leq$ 125°C (@$T_C \leq$ 100°C).

Control Part

Item	Symbol	Condition	Rating	Unit
Control Supply Voltage	V_{CC}	Applied between V_{CC} - COM	20	V
Input Signal Voltage	V_{IN}	Applied between IN - COM	-0.3~17	V
Fault Output Supply Voltage	V_{FO}	Applied between V_{FO} - COM	-0.3~V_{CC}+0.3	V
Fault Output Current	I_{FO}	Sink Current at V_{FO} Pin	5	mA
Current Sensing Input Voltage	V_{SC}	Applied between C_{SC} - COM	-0.3~V_{CC}+0.3	V

Total System

Item	Symbol	Condition	Rating	Unit
Module Case Operation Temperature	T_C		-20 ~ 100	°C
Storage Temperature	T_{STG}		-40 ~ 150	°C
Isolation Voltage	V_{ISO}	60Hz, Sinusoidal, AC 1 minute, Connection Pins to DBC	2500	V_{rms}

Thermal Resistance

Item	Symbol	Condition	Min.	Typ.	Max.	Unit
Junction to Case Thermal Resistance (Referenced to PKG center)	$R_{\theta(j-c)Q}$	IGBT	-	-	0.7	°C/W
	$R_{\theta(j-c)HD}$	High-side diode	-	-	1.5	°C/W
	$R_{\theta(j-c)LD}$	Low-side diode	-	-	0.85	°C/W

Note :

2. For the measurement point of case temperature(T_C), please refer to Fig. 2.

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Electrical Characteristics (T_J = 25°C, Unless Otherwise Specified)

Converter Part

Item	Symbol	Condition	Min.	Typ.	Max.	Unit
IGBT saturation voltage	$V_{CE(sat)}$	V_{CC} =15V, V_{IN} = 5V; I_C =50A	-	2.0	2.5	V
High-side diode voltage	V_{FH}	I_F = 50A	-	2.4	2.9	V
Low-side diode voltage	V_{FL}	I_F = 50A	-	1.2	1.6	V
Switching Times	t_{ON}	V_{PN} = 400V, V_{CC} = 15V, I_C =60A V_{IN} = 0V ↔ 5V, Inductive Load (Note 3)	-	560	-	ns
	$t_{C(ON)}$		-	270	-	ns
	t_{OFF}		-	520	-	ns
	$t_{C(OFF)}$		-	110	-	ns
	t_{rr}		-	44	-	ns
	I_{rr}		-	6.5	-	A
Current sensing resistor	R_{SENSE}		1.8	2.0	2.2	mΩ
Collector - emitter Leakage Current	I_{CES}	V_{CE} = V_{CES}	-	-	250	μA

Note

3. t_{ON} and t_{OFF} include the propagation delay time of the internal drive IC. $t_{C(ON)}$ and $t_{C(OFF)}$ are the switching time of IGBT itself under the given gate driving condition internally. For the detailed information, please see Fig. 4

Control Part

Item	Symbol	Condition	Min.	Typ.	Max.	Unit
Quiescent V_{CC} Supply Current	I_{QCCL}	V_{CC} = 15V, IN = 0V | V_{CC} - COM	-	-	26	mA
Fault Output Voltage	V_{FOH}	V_{SC} = 0V, V_{FO} Circuit: 4.7kΩ to 5V Pull-up	4.5	-	-	V
	V_{FOL}	V_{SC} = 1V, V_{FO} Circuit: 4.7kΩ to 5V Pull-up	-	-	0.8	V
Over Current Trip Level	$V_{SC(ref)}$	V_{CC} = 15V	0.45	0.5	0.55	V
Supply Circuit Under-Voltage Protection	UV_{CCD}	Detection Level	10.7	11.9	13.0	V
	UV_{CCR}	Reset Level	11.2	12.4	13.2	V
Fault-out Pulse Width	t_{FOD}	C_{FOD} = 33nF (Note 4)	1.4	1.8	2.0	ms
ON Threshold Voltage	$V_{IN(ON)}$	Applied between IN - COM	3.0	-	-	V
OFF Threshold Voltage	$V_{IN(OFF)}$		-	-	0.8	V
Resistance of Thermistor	R_{TH}	@ T_C = 25°C (Note Fig. 9)	-	50	-	kΩ
		@ T_C = 80°C (Note Fig. 9)	-	5.76	-	kΩ

Note

4. The fault-out pulse width t_{FOD} depends on the capacitance value of C_{FOD} according to the following approximate equation : $C_{FOD} = 18.3 \times 10^{-6} \times t_{FOD}$[F]

Recommended Operating conditions

Item	Symbol	Condition	Min.	Typ.	Max.	Unit
Input Supply Voltage	V_I	Applied between R - S	180	-	264	V_{rms}
Output Voltage	V_{PN}	Applied between P - N	-	280	400	V
Control Supply Voltage	V_{CC}	Applied between V_{CC} - COM	13.5	15	16.5	V
Control Supply Variation	dV_{CC}/dt	Applied between IN - COM	-1	-	1	V/μs
PWM Input Signal	f_{PWM}	$T_C \leq$ 100°C, $T_J \leq$ 125°C, Per IGBT	-	20	-	kHz

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Electrical Characteristics

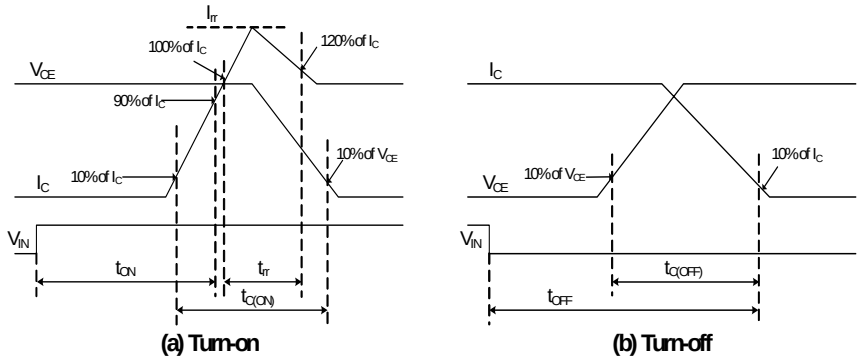


Fig. 4. Switching Time Definition

Mechanical Characteristics and Ratings

Item	Condition		Limits			Units
			Min.	Typ.	Max.	
Mounting Torque	Mounting Screw: - M3	Recommended 0.62N•m	0.51	0.62	0.72	N•m
Device Flatness	Note Fig. 5		0	-	+120	μm
Weight			-	15.00	-	g

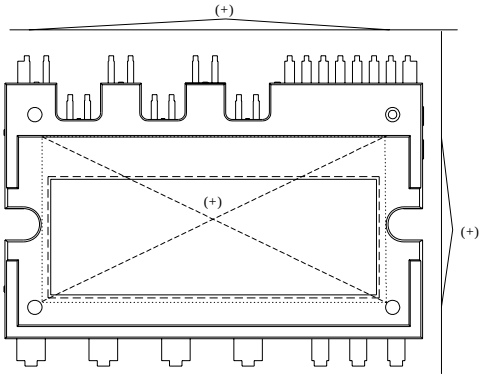
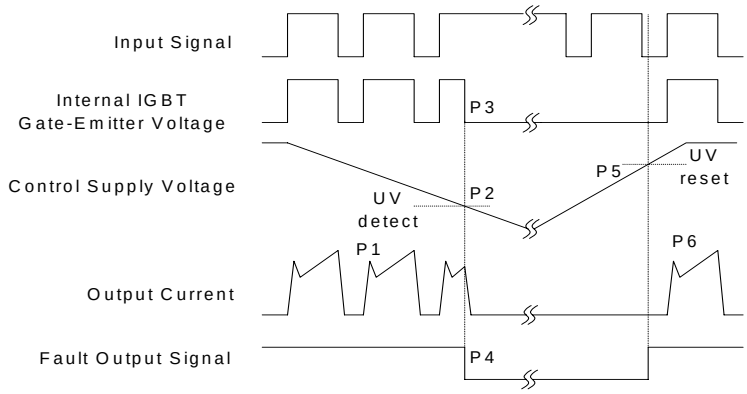


Fig. 5. Flatness Measurement Position

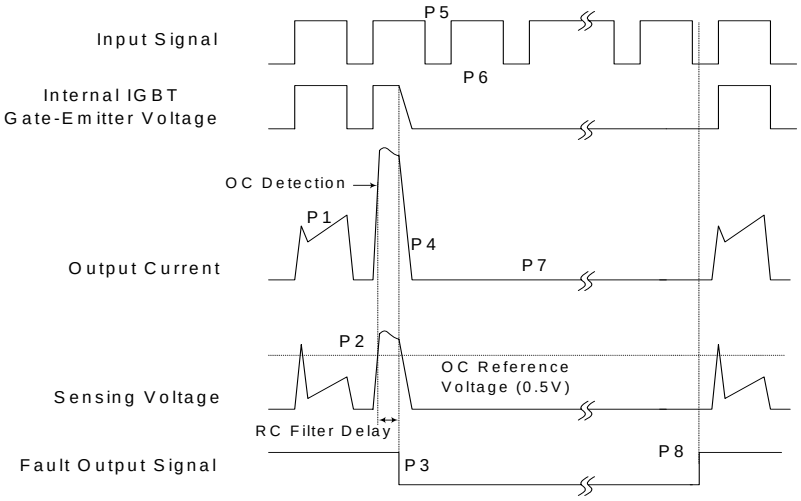
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Time Charts of SPMs Protective Function



P1 : Normal operation - IGBT ON and conducting current
P2 : Under voltage detection
P3 : IGBT gate interrupt
P4 : Fault signal generation
P5 : Under voltage reset
P6 : Normal operation - IGBT ON and conducting current

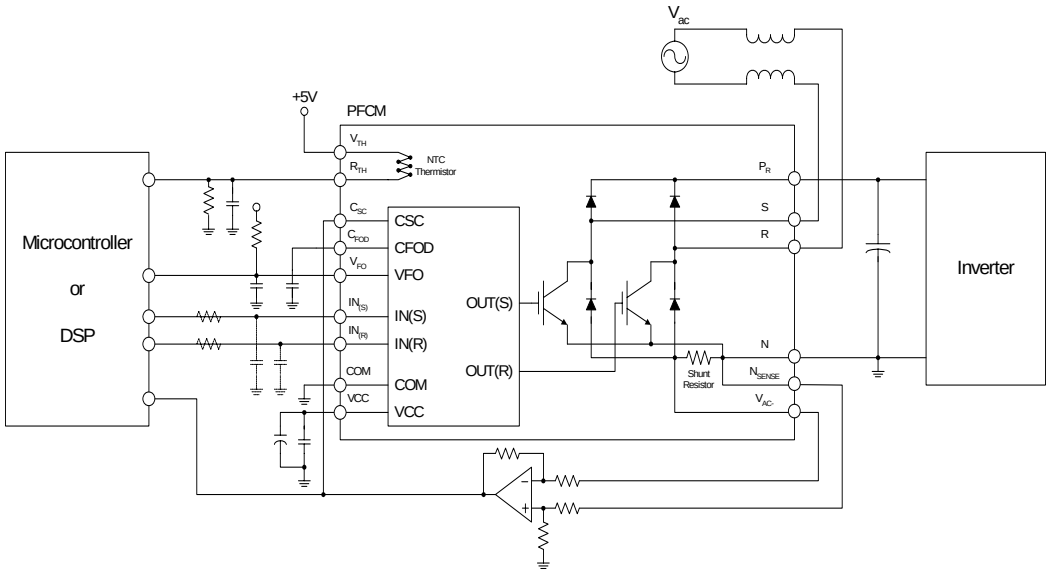
Fig. 6. Under-Voltage Protection



P1 : Normal operation - IGBT ON and conducting current
P2 : Over current detection
P3 : IGBT gate interrupt / Fault signal generation
P4 : IGBT is slowly turned off
P5 : IGBT OFF signal
P6 : IGBT ON signal - but IGBT cannot be turned on during the fault Output activation
P7 : IGBT OFF state
P8 : Fault Output reset and normal operation start

Fig. 7. Over Current Protection

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Note :
1) For the over-current protection, please set the delay time in the range 3~4μs.

Fig. 8. Application Example

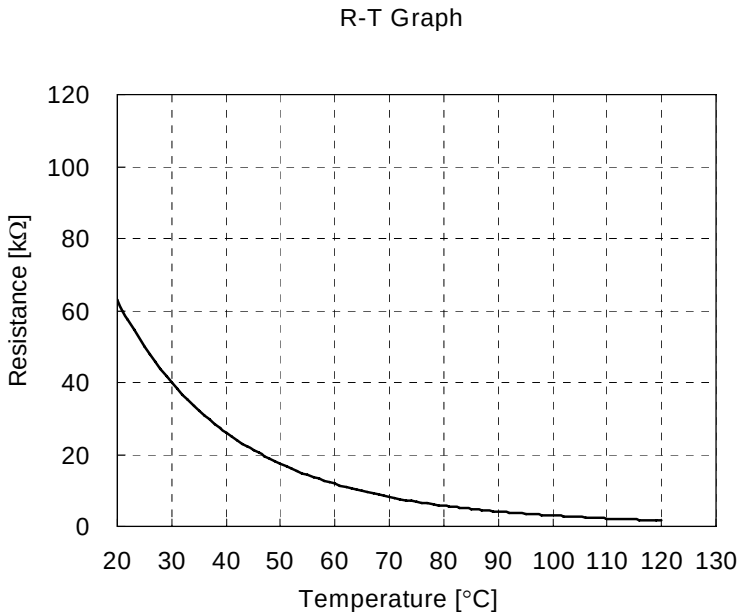
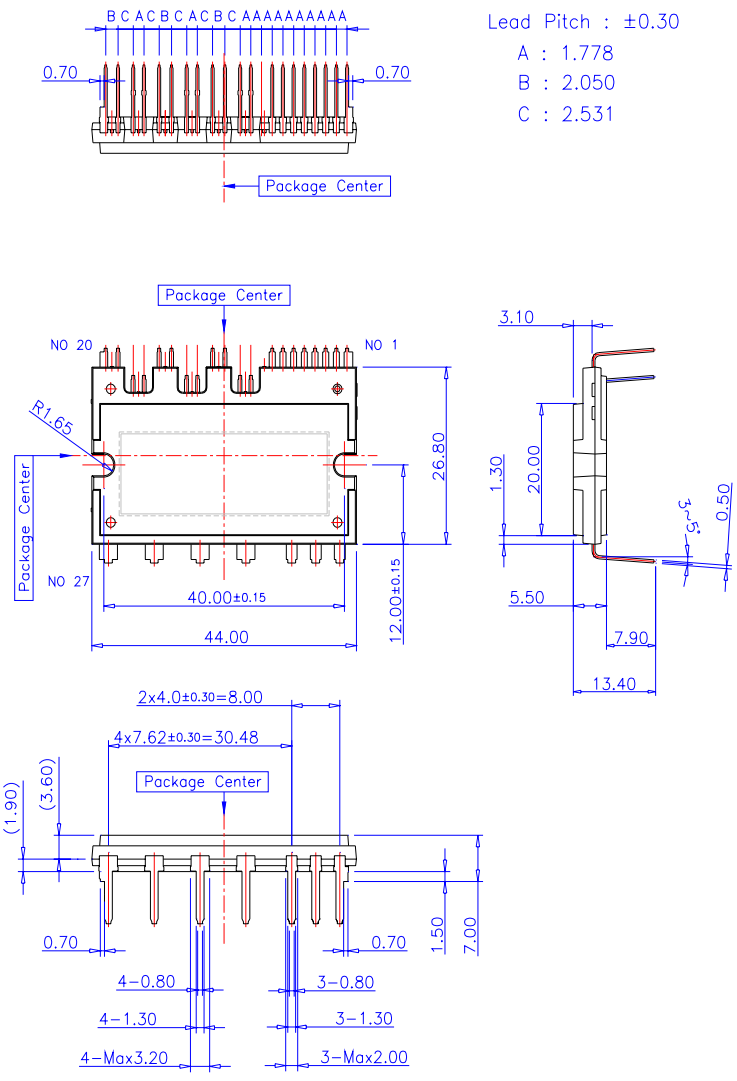


Fig. 9. R-T Curve of the Built-in Thermistor

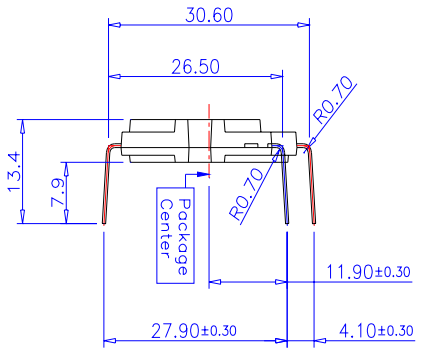
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Detailed Package Outline Drawings

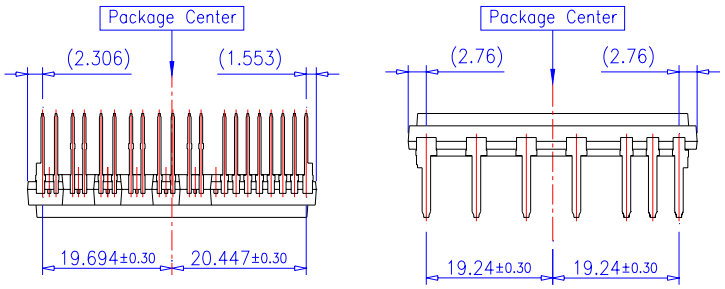


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Detailed Package Outline Drawings



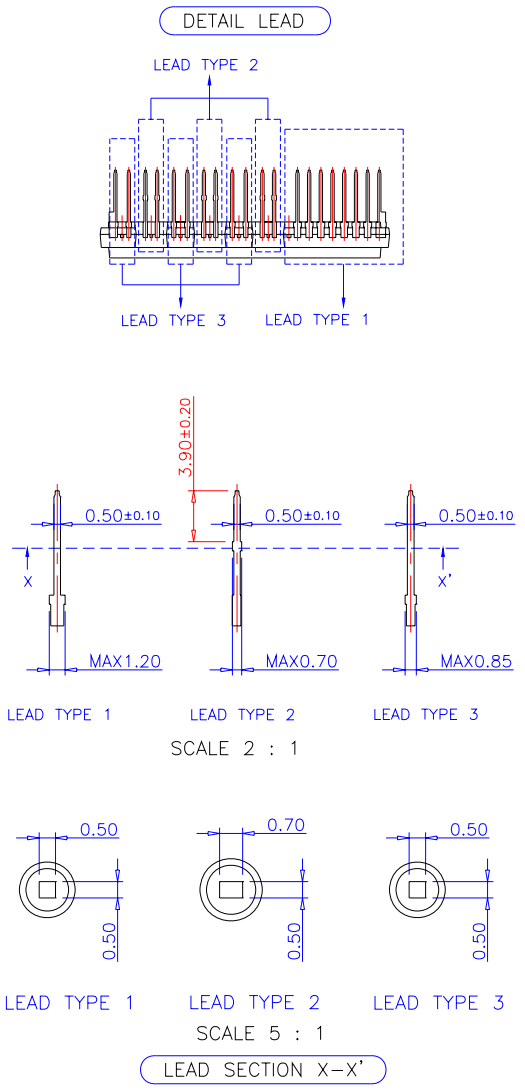
Lead Forming Dimension



PKG Center to Lead Distance

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Detailed Package Outline Drawings



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